

**Notice of References Cited**

Application/Control No.

10/597,200

Applicant(s)/Patent Under  
Reexamination  
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Examiner

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Art Unit

2818

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0001170	01-2003	Shibata et al.	257/189
*	B	US-6,326,294	12-2001	Jang et al.	438/604
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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